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| Search Notes | Application/Control No. | Applicant(s)/Patent Under Reexamination |
| | 10580401 | CHEN ET AL. |
|  | Examiner | Art Unit |
| | Awet Haile | 2474 |

SEARCHED

| Class | Subclass | Date | Examiner |
|--------------|---------------------------------------|-------------|-----------------|
| 370 | 395.2, 395.5, 252 | 10/31/2009 | MA |
| 370 | 231, 232, 233, 235, 236.1, 395.5, 468 | 5/7/2010 | A.H |
| Above | Updated | 9/30/2010 | A.H |
| Above | Updated | 2/2/2011 | A.H |

SEARCH NOTES

| Search Notes | Date | Examiner |
|---|-------------|-----------------|
| East Search (updated) | 2/17/2009 | MA |
| Inventor's/Asignee's Search | 10/31/2009 | MA |
| NPL(IEEE, Books and so) | 10/31/2009 | MA |
| PLUS Search | 10/31/2009 | MA |
| Google/patents/scholar | 10/31/2009 | Ma |
| East text search | 5/7/2010 | A.H |
| East class/subclass limited search 370/395.5, 370/236.1 | 5/7/2010 | A.H |
| Inventor's search | 5/7/2010 | A.H |
| East class/subclass limited search 370/395.5, 370/236.1 | 9/30/2010 | A.H |
| Inventor's search | 9/30/2010 | A.H |
| East text search | 9/30/2010 | A.H |
| East class/subclass limited search 370/395.5, 370/236.1 | 2/2/2011 | A.H |
| Inventor's search | 2/2/2011 | A.H |

INTERFERENCE SEARCH

| Class | Subclass | Date | Examiner |
|--------------|-----------------|-------------|-----------------|
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